

**• General Description**

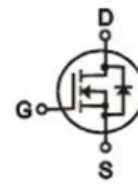
The ZM140N10HI combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

**• Features**

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

**• Application**

- Synchronous Rectification for AC-DC/DC-DC converter
- BLDC Motor driver

**• Product Summary**


$V_{DS} = 100V$

$R_{DS(ON)} = 14m\Omega$

$I_D = 50A$



TO-251


**• Ordering Information:**

Part NO.	ZM140N10HI
Marking	ZM140N10H
Packing Information	TUBE
Basic ordering unit (pcs)	900

**• Absolute Maximum Ratings ( $T_C = 25^\circ C$ )**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D @ TC=25^\circ C$	50	A
	$I_D @ TC=75^\circ C$	38	A
	$I_D @ TC=100^\circ C$	31	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	150	A
Total Power Dissipation	$P_D @ TC=25^\circ C$	85	W
Total Power Dissipation	$P_D @ TA=25^\circ C$	3.4	W
Operating Junction Temperature	$T_J$	-55 to 150	$^\circ C$
Storage Temperature	$T_{STG}$	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy @ $L=0.1mH$	$E_{AS}$	80	mJ
Avalanche Current @ $L=0.1mH$	$I_{AS}$	40	A

**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.5	$^{\circ}C/W$
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	37	$^{\circ}C/W$
Soldering temperature, wave soldering for 10s	$T_{sold}$	-	-	265	$^{\circ}C$

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	100			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2		4	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=100V, V_{GS}=0V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$		14	17	$m\Omega$
		$V_{GS}=4.5V, I_D=12A$		17	20	$m\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=25V, I_D=10A$		20		S

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=30V$ $f = 1MHz$	-	4200	-	$\mu F$
Output capacitance	$C_{oss}$		-	184	-	
Reverse transfer capacitance	$C_{rss}$		-	150	-	

**•Gate Charge characteristics( $T_a = 25^{\circ}C$ )**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Total gate charge	$Q_g$	$V_{DD} = 30V$ $I_D = 20A$ $V_{GS} = 10V$	-	74	-	nC
Gate - Source charge	$Q_{gs}$		-	20	-	
Gate - Drain charge	$Q_{gd}$		-	10	-	

Note: ① Pulse Test : Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$  ;

Fig.1 Gate-Charge Characteristics

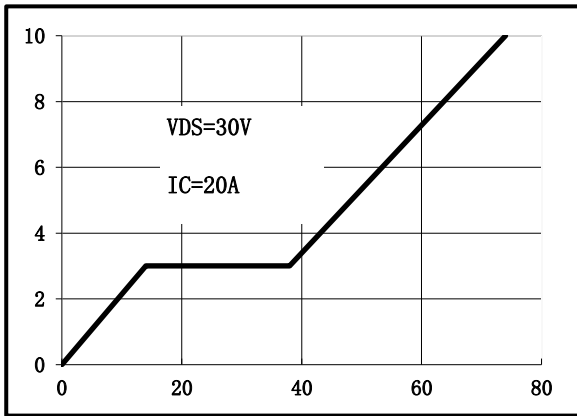


Fig.2 Capacitance Characteristics

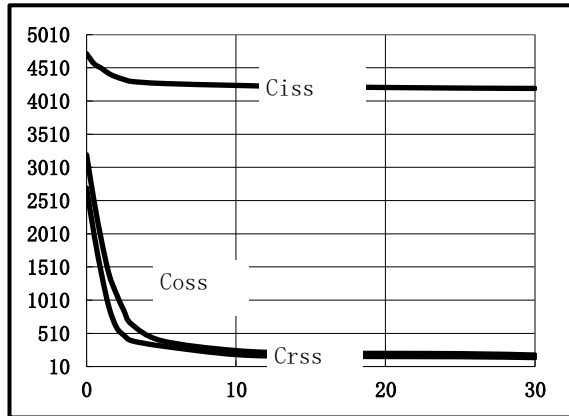


Fig.3 Power Dissipation

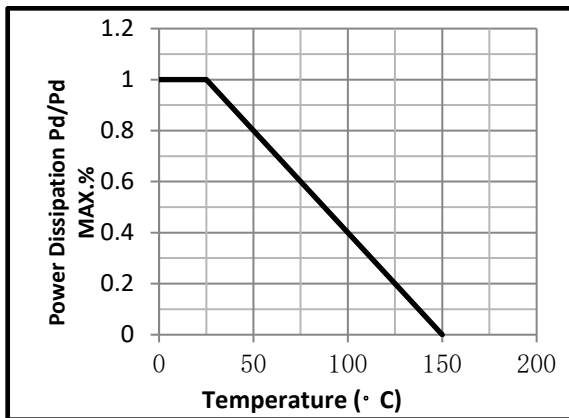


Fig.4 Typical output Characteristics

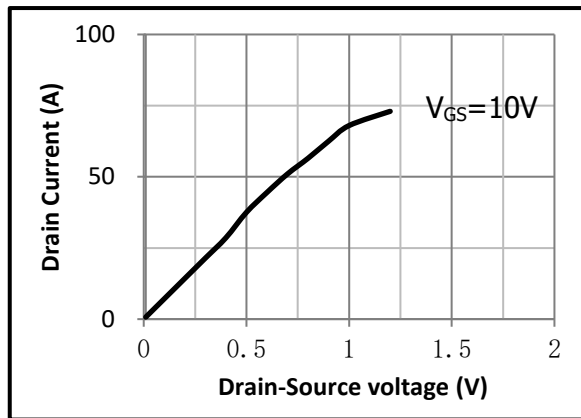


Fig.5 Threshold Voltage V.S Junction Temperature

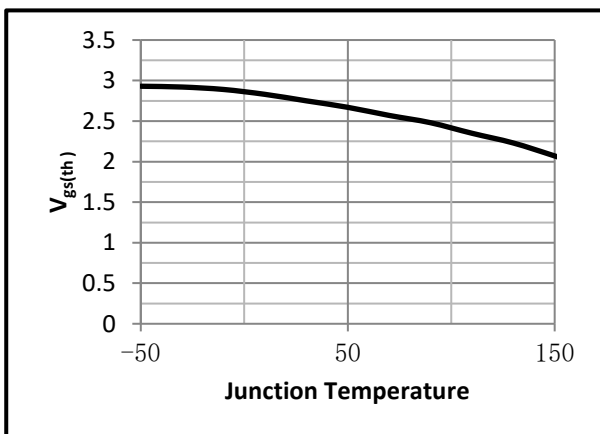


Fig.6 Resistance V.S Drain Current

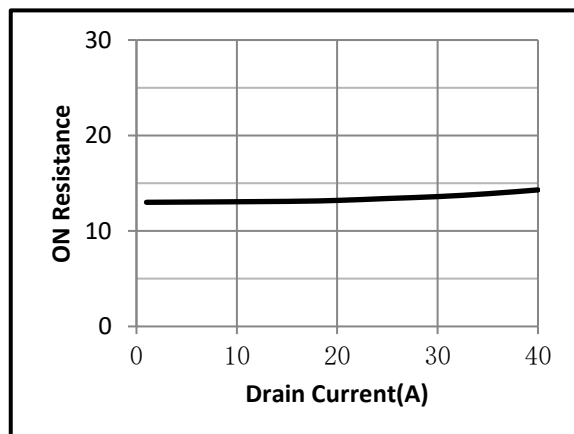


Fig.7 On-Resistance VS Gate Source Voltage

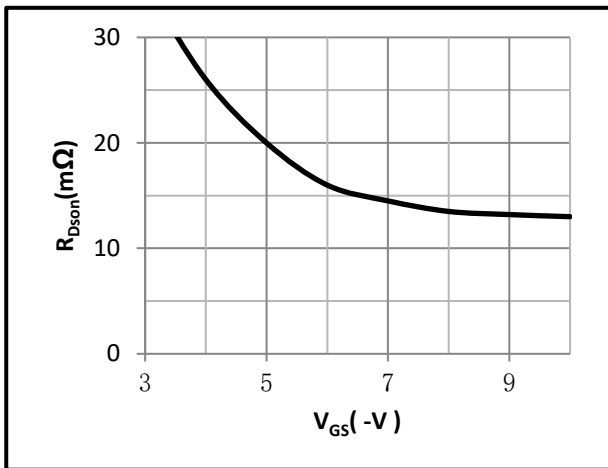


Fig.8 On-Resistance V.S Junction Temperature

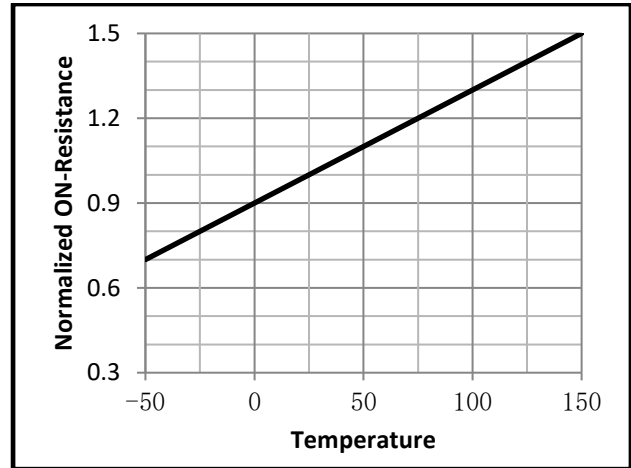


Fig.9 SOA Maximum Safe Operating Area

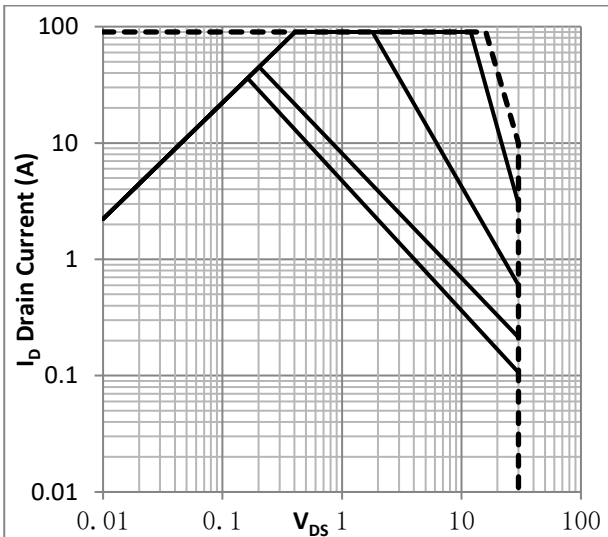


Fig.10  $I_D$ -Junction Temperature

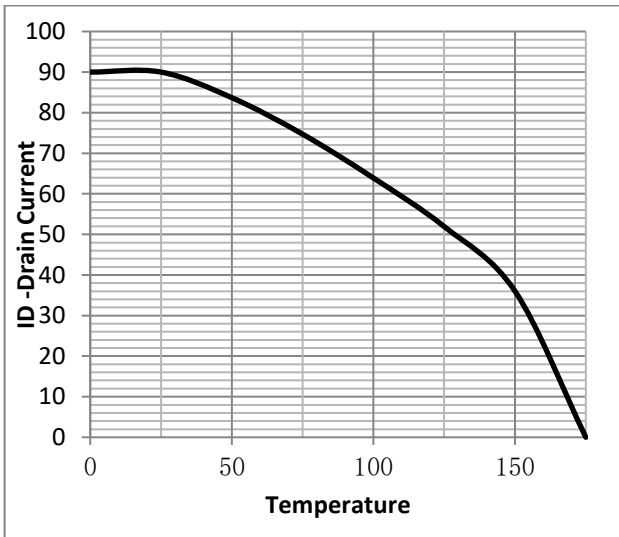


Fig.11 Switching Time Measurement Circuit

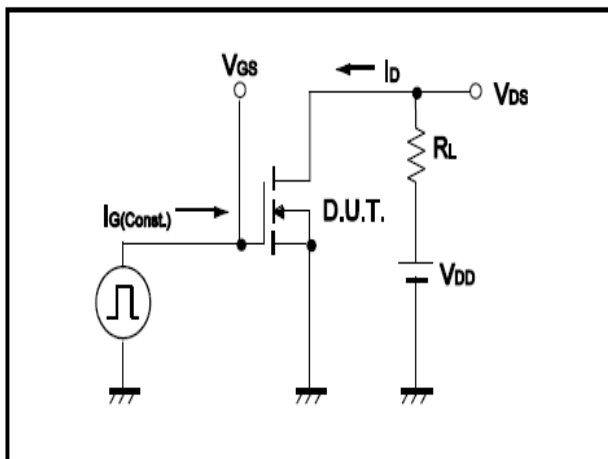


Fig.12 Gate Charge Waveform

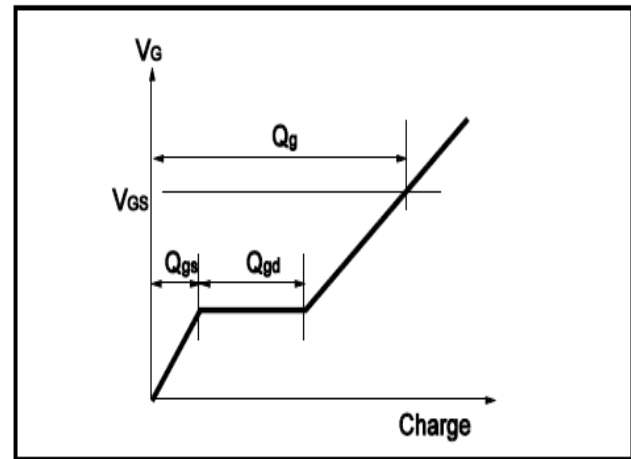


Fig.13 Resistive Switching Test Circuit

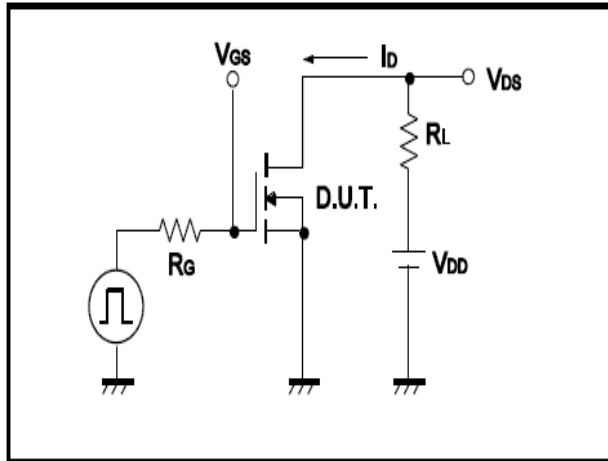
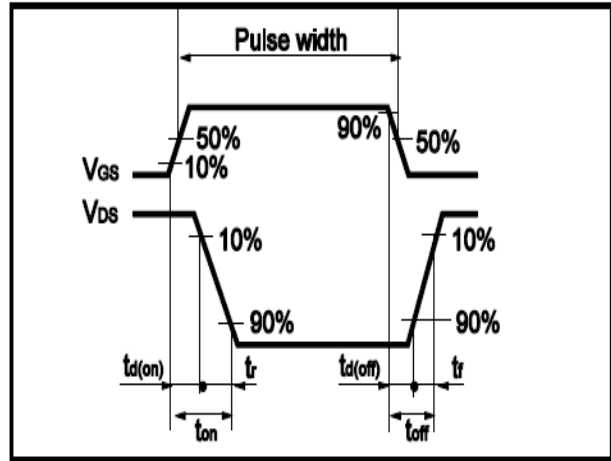


Fig.14 Resistive Switching Test Waveform





•Dimensions(TO-251)

Unit: mm

SYMBOL	min	max	SYMBOL	min	max
A	2.10	2.50	D	6.35	6.80
A1	0.95	1.30	D1	5.10	5.50
B	0.80	1.25	E	5.30	6.30
b	0.50	0.80	e	2.24	2.35
b1	0.70	0.90	E1	4.43	4.73
c	0.45	0.60	L	7.00	9.40
c1	0.45	0.60			

